

<b>Notice of References Cited</b>	Application/Control No. 09/747,645	Applicant(s)/Patent Under Reexamination GUPTA ET AL.	
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	V	"A SAS Institute White Paper: The Quality Data Warehouse – serving the analytical needs of the manufacturing enterprise", © 1999, SAS Institute, pp.1-11
	W	Davis, Robert D; et al.; "Detecting Process Shifts with X-bar charts", First Quarter 1993, Production and Inventory Management Journal, 34, 1, ABI/INFORM Global, p.25
	X	Harry, Mikel J; "Six Sigma: A breakthrough strategy for profitability", May 1998, Quality Progress, 31, 5; ABI/INFORM Global, p.60,

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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